

# Shin Mou

## List of Publications by Year in descending order

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22  
papers

1,454  
citations

567281

15  
h-index

713466

21  
g-index

22  
all docs

22  
docs citations

22  
times ranked

1054  
citing authors

#	ARTICLE	IF	CITATIONS
1	Demonstration of high mobility and quantum transport in modulation-doped $\hat{\Gamma}^2$ -(Al <sub>x</sub> Ga <sub>1-x</sub> ) <sub>2</sub> O <sub>3</sub> /Ga <sub>2</sub> O <sub>3</sub> heterostructures. Applied Physics Letters, 2018, 112, .	3.3	264
2	Donors and deep acceptors in $\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> . Applied Physics Letters, 2018, 113, .	3.3	203
3	$\hat{\Gamma}^2$ -Gallium oxide power electronics. APL Materials, 2022, 10, .	5.1	184
4	Ge-Doped $\{\eta\}$ -Ga <sub>2</sub> O <sub>3</sub> MOSFETs. IEEE Electron Device Letters, 2017, 38, 775-778.	3.9	165
5	Heteroepitaxy of N-type $\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> thin films on sapphire substrate by low pressure chemical vapor deposition. Applied Physics Letters, 2016, 109, .	3.3	122
6	Lateral $\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> field effect transistors. Semiconductor Science and Technology, 2020, 35, 013002.	2.0	85
7	Incomplete Ionization of a 110-meV Unintentional Donor in $\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> and its Effect on Power Devices. Scientific Reports, 2017, 7, 13218.	3.3	84
8	Towards High-Mobility Heteroepitaxial $\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> on Sapphire $\hat{\Gamma}^2$ Dependence on The Substrate Off-Axis Angle. Physica Status Solidi (A) Applications and Materials Science, 2018, 215, 1700467.	1.8	84
9	MOCVD growth of high purity Ga <sub>2</sub> O <sub>3</sub> epitaxial films using trimethylgallium precursor. Applied Physics Letters, 2020, 117, .	3.3	77
10	Adsorption-controlled growth of Ga <sub>2</sub> O <sub>3</sub> by suboxide molecular-beam epitaxy. APL Materials, 2021, 9, .	5.1	38
11	Pulsed Power Performance of $\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> MOSFETs at L-Band. IEEE Electron Device Letters, 2020, 41, 989-992.	3.9	32
12	Toward high voltage radio frequency devices in $\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> . Applied Physics Letters, 2020, 117, .	3.3	23
13	$\hat{\Gamma}^3$ -phase inclusions as common structural defects in alloyed $\hat{\Gamma}^2$ -(Al <sub>x</sub> Ga <sub>1-x</sub> ) <sub>2</sub> O <sub>3</sub> and doped $\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> films. APL Materials, 2021, 9, .	5.1	23
14	Reduction of unintentional Si doping in $\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> grown via plasma-assisted molecular beam epitaxy. Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films, 2020, 38, 043403.	2.1	20
15	$\hat{\Gamma}^2$ -Ga <sub>2</sub> O <sub>3</sub> defect study by steady-state capacitance spectroscopy. Japanese Journal of Applied Physics, 2018, 57, 091101.	1.5	17
16	Si doping in MOCVD grown (010) $\hat{\Gamma}^2$ -(Al <sub>x</sub> Ga <sub>1-x</sub> ) <sub>2</sub> O <sub>3</sub> thin films. Journal of Applied Physics, 2022, 131, .	2.5	15
17	Edge Doping Effect to the Surface Plasmon Resonances in Graphene Nanoribbons. Journal of Physical Chemistry C, 2019, 123, 19820-19827.	3.1	8
18	Microwave imaging of etching-induced surface impedance modulation of graphene monolayer. Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films, 2018, 36, 05G508.	2.1	3

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19	Study of defects in $\hat{2}$ -Ga <sub>2</sub> O <sub>3</sub> by isothermal capacitance transient spectroscopy. Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics, 2019, 37, 041204.	1.2	3
20	Tailoring the Potential Landscape and Electrical Properties of 2D MoS <sub>2</sub> using Gold Nanostructures of Different Coverage Density. Journal of Physical Chemistry C, 2020, 124, 6461-6466.	3.1	3
21	Zeeman spin-splitting in the (010) $\hat{2}$ -Ga <sub>2</sub> O <sub>3</sub> two-dimensional electron gas. Applied Physics Letters, 2019, 115, .	3.3	1
22	Electrical Properties 1. Springer Series in Materials Science, 2020, , 389-405.	0.6	0